


<b>Search Notes</b>  	<b>Application/Control No.</b>  10652672	<b>Applicant(s)/Patent Under Reexamination</b>  ZIELINSKI ET AL.
	<b>Examiner</b>  PHILIP C LEE	<b>Art Unit</b>  2152

SEARCHED			
Class	Subclass	Date	Examiner
709	226,227,228,230,220,219,203	6/7/08	/pl/
370	401,389,351,469,237	6/7/08	/pl/
718	105	6/7/08	/pl/

SEARCH NOTES		
Search Notes	Date	Examiner
keywords search in EAST	6/7/08	/pl/
keywords search in 709/226,227,228,230,220,219,203; 370/401,389,351,469,237; 718/105 in EAST	6/7/08	/pl/
Google search	6/7/08	/pl/
ACM/IEEE search	6/7/08	/pl/
Search 709/226,227,228,230,220,219,203; 370/401,389,351,469,237; 718/105 in PG Pub	6/7/08	/pl/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	226,227,228,230,220,219,203	6/7/08	/pl/
370	401,389,351,469,237	6/7/08	/pl/
718	105	6/7/08	/pl/